มาตรฐานผลิตภัณฑ์อุตสาหกรรม

THAI INDUSTRIAL STANDARD

มอก. 1459 – 2552

IEC 61000-4-10(2001-03)

ความเข้ากันได้ทางแม่เหล็กไฟฟ้า

เล่ม 4 เทคนิคการทดสอบและการวัด

ส่วนที่ 10 การทดสอบภูมิคุ้มกันสนามแม่เหล็กแกว่งแบบหน่วง

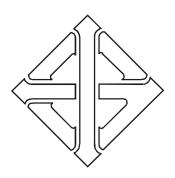
ELECTROMAGNETIC COMPATIBILITY (EMC)

PART 4: TESTING AND MEASUREMENT TECHNIQUES SECTION 10: DAMPED OSCILLATORY MAGNETIC FIELD IMMUNITY TEST

สำนักงานมาตรฐานผลิตภัณฑ์อุตสาหกรรม

กระทรวงอุตสาหกรรม

ICS 33.100.20



มาตรฐานผลิตภัณฑ์อุตสาหกรรม ความเข้ากันได้ทางแม่เหล็กไฟฟ้า

เล่ม 4 เทคนิคการทดสอบและการวัด ส่วนที่ 10 การทดสอบภูมิคุ้มกันสนามแม่เหล็กแกว่งแบบหน่วง

มอก. 1459 – 2552

สำนักงานมาตรฐานผลิตภัณฑ์อุตสาหกรรม กระทรวงอุตสาหกรรม ถนนพระรามที่ 6 กรุงเทพฯ 10400 โทรศัพท์ 02 202 3300

ประกาศในราชกิจจานุเบกษา ฉบับประกาศและงานทั่วไป เล่ม 127 ตอนพิเศษ 70ง วันที่ 4 มิถุนายน พุทธศักราช 2553 มาตรฐานผลิตภัณฑ์อุตสาหกรรมความเข้ากันได้ทางแม่เหล็กไฟฟ้า เล่ม 4 เทคนิคการทดสอบและการวัด ส่วนที่ 10 การทดสอบภูมิคุ้มกันสนามแม่เหล็กแกว่งแบบหน่วง ได้ประกาศใช้ครั้งแรกโดยรับ IEC 1000-4-10(1993-06) Electromagnetic compatibility (EMC) - Part4: Testing and measurement techniques - Section 10: Damped oscillatory magnetic field immunity test มาใช้ในระดับเหมือนกันทุกประการ (Identical) โดยใช้IEC ฉบับภาษาอังกฤษ เป็นหลัก โดยประกาศในราชกิจจานุเบกษา ฉบับประกาศทั่วไป เล่มที่ 115 ตอนที่ 31ง วันที่ 16 เมษายน พุทธศักราช 2541

เนื่องจาก IEC ได้แก้ไขปรับปรุงมาตรฐาน IEC 1000-4-10(1993-06) เป็น IEC 61000-4-10 (2001-03) จึงได้ยกเลิกมาตรฐานเดิมและกำหนดมาตรฐานใหม่โดยรับ IEC 61000-4-10 (2001-03) Electromagnetic Compatibility (EMC) Part 4-10: Testing and measurement techniques- Dumped oscillatory magnetic field immunity test มาใช้ในระดับเหมือนกันทุกประการโดยใช้มาตรฐาน IEC ฉบับภาษาอังกฤษเป็นหลัก

คณะกรรมการมาตรฐานผลิตภัณฑ์อุตสาหกรรมได้พิจารณามาตรฐานนี้แล้ว เห็นสมควรเสนอรัฐมนตรีประกาศตาม มาตรา 15 แห่งพระราชบัญญัติมาตรฐานผลิตภัณฑ์อุตสาหกรรม พ.ศ. 2511



ประกาศกระทรวงอุตสาหกรรม ฉบับที่ 4159 (พ.ศ. 2552) ออกตามความในพระราชบัญญัติมาตรฐานผลิตภัณฑ์อุตสาหกรรม พ.ศ. 2511 เรื่อง ยกเลิกและกำหนดมาตรฐานผลิตภัณฑ์อุตสาหกรรม ความเข้ากันได้ทางแม่เหล็กไฟฟ้า เล่ม 4 เทคนิคการทดสอบและการวัด ส่วนที่ 10 การทดสอบภูมิคุ้มกันสนามแม่เหล็กแกว่งแบบหน่วง

โดยที่เป็นการสมควรปรับปรุงมาตรฐานผลิตภัณฑ์อุตสาหกรรม ความเข้ากันได้ทางแม่เหล็กไฟฟ้า เล่ม 4 เทคนิคการทดสอบและการวัด ส่วนที่ 10 การทดสอบภูมิคุ้มกันสนามแม่เหล็กแกว่งแบบหน่วง มาตรฐานเลขที่ มอก.1459-2540

อาศัยอำนาจตามความในมาตรา 15 แห่งพระราชบัญญัติมาตรฐานผลิตภัณฑ์อุตสาหกรรม พ.ศ. 2511 รัฐมนตรีว่าการกระทรวงอุตสาหกรรมออกประกาศยกเลิกประกาศกระทรวงอุตสาหกรรม ฉบับที่ 2361 (พ.ศ.2541) ออกตามความในพระราชบัญญัติมาตรฐานผลิตภัณฑ์อุตสาหกรรม พ.ศ.2511 เรื่อง กำหนดมาตรฐานผลิตภัณฑ์ อุตสาหกรรม ความเข้ากันได้ทางแม่เหล็กไฟฟ้า เล่ม 4 เทคนิคการทดสอบและการวัด ส่วนที่ 10 การทดสอบภูมิคุ้มกัน สนามแม่เหล็กแกว่งแบบหน่วง ลงวันที่ 9 กุมภาพันธ์ พ.ศ.2541 และออกประกาศกำหนดมาตรฐานผลิตภัณฑ์ อุตสาหกรรม ความเข้ากันได้ทางแม่เหล็กไฟฟ้า เล่ม 4 เทคนิคการทดสอบและการวัด ส่วนที่ 10 การทดสอบภูมิคุ้มกัน สนามแม่เหล็กแกว่งแบบหน่วง ลงวันที่ 9 กุมภาพันธ์ พ.ศ.2541 และออกประกาศกำหนดมาตรฐานผลิตภัณฑ์ อุตสาหกรรม ความเข้ากันได้ทางแม่เหล็กไฟฟ้า เล่ม 4 เทคนิคการทดสอบและการวัด ส่วนที่ 10 การทดสอบภูมิคุ้มกัน สนามแม่เหล็กแกว่งแบบหน่วง มาตรฐานเลขที่ มอก.1459-2552 ขึ้นใหม่ ดังมีรายการละเอียดต่อท้ายประกาศนี้ ทั้งนี้ให้มีผลตั้งแต่วันถัดจากวันที่ประกาศในราชกิจจานุเบกษา เป็นต้นไป

> ประกาศ ณ วันที่ 29 ธันวาคม พ.ศ. 2552 ชาญชัย ชัยรุ่งเรือง รัฐมนตรีว่าการกระทรวงอุตสาหกรรม

มาตรฐานผลิตภัณฑ์อุตสาหกรรม ความเข้ากันใด้ทางแม่เหล็กไฟฟ้า

เล่ม 4 เทคนิคการทดสอบและการวัด ส่วนที่ 10 การทดสอบภูมิคุ้มกันสนามแม่เหล็กแกว่งแบบหน่วง

มาตรฐานผลิตภัณฑ์อุตสาหกรรมนี้กำหนดขึ้นโดยรับ IEC 61000-4-10 (2001-03) Electromagnetic Compatibility (EMC) Part 4-10: Testing and measurement techniques- Dumped oscillatory magnetic field immunity test มาใช้ในระดับเหมือนกันทุกประการ (identical) โดยใช้ IEC ฉบับภาษาอังกฤษเป็นหลัก

มาตรฐานผลิตภัณฑ์อุตสาหกรรมนี้เกี่ยวข้องกับคุณลักษณะที่ต้องการทางด้านภูมิคุ้มกันของบริภัณฑ์ต่อการรบกวน ทางแม่เหล็กแกว่งแบบหน่วง (เฉพาะภายใต้สภาวะการทำงาน) ซึ่งเกี่ยวข้องกับโรงงานอุตสาหกรรมและโรงงาน ผลิตไฟฟ้า หรือสถานีไฟฟ้าย่อยแรงดันไฟฟ้าปานกลางและแรงดันไฟฟ้าสูง

การประยุกต์ใช้มาตรฐานนี้กับบริภัณฑ์ที่ติดตั้งในสถานที่ต่างกันถูกกำหนดโดยการปรากฏของปรากฎการณ์ธรรมชาติ ที่ระบุไว้ในข้อ 3

มาตรฐานนี้ไม่ได้พิจารณาการรบกวนเนื่องจากการเชื่อมต่อเชิงความจุไฟฟ้าหรือเชิงเหนี่ยวนำไฟฟ้าในสายเคเบิลหรือส่วนอื่น ๆ ของสิ่งติดตั้งภาคสนาม

มาตรฐานอื่น IEC อื่น ๆ ซึ่งเกี่ยวข้องกับการรบกวนที่ถูกนำมาจะครอบคลุมลักษณะดังกล่าวนี้

วัตถุประสงค์ของมาตรฐานนี้เพื่อจัดตั้งพื้นฐานซึ่งใช้ร่วมกันและทำซ้ำสำหรับการประเมินสมรรถนะของบริภัณฑ์ไฟฟ้า และอิเล็กทรอนิกส์ สถานีไฟฟ้าย่อยแรงดันไฟฟ้าปานกลางและแรงดันไฟฟ้าสูง สำหรับการใช้งานภายในที่อยู่อาศัย การพาณิชย์ และอุตสาหกรรม เมื่ออยู่ภายใต้สนามแม่เหล็กที่แกว่งหน่วง

มาตรฐานนี้ได้นิยาม

- ระดับการทดสอบที่แนะนำ
- บริภัณฑ์ทดสอบ
- การจัดเครื่องมือทดสอบ
- กระบวนการการทดสอบ

รายละเอียดให้เป็นไปตาม IEC 61000-4-10 (2001-03)

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เอกสารนี้เป็นสิทธิ์ของ IEC หากมิได้กำหนดไว้เป็นอย่างอื่นห้ามนำมาตรฐานฉบับนี้หรือ ส่วนหนึ่งส่วนใดไปทำซ้ำหรือใช้ประโยชน์ในรูปแบบ หรือโดยวิธีใด ๆ ไม่ว่าจะเป็นรูปแบบ อิเล็กทรอนิกส์หรือทางกล รวมถึงการถ่ายสำเนา ถ่ายไมโครฟิลม์ โดยไม่ได้รับอนุญาตเป็น ลายลักษณ์อักษรจาก IEC ตามที่อยู่ข้างล่างหรือจากสมาชิก IEC ในประเทศของผู้ร้องขอ

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

ELECTROMAGNETIC COMPATIBILITY (EMC) -

Part 4-10: Testing and measurement techniques – Damped oscillatory magnetic field immunity test

FOREWORD

- 1) The IEC (International Electrotechnical Commission) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of the IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, the IEC publishes International Standards. Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. The IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of the IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested National Committees.
- 3) The documents produced have the form of recommendations for international use and are published in the form of standards, technical specifications, technical reports or guides and they are accepted by the National Committees in that sense.
- 4) In order to promote international unification, IEC National Committees undertake to apply IEC International Standards transparently to the maximum extent possible in their national and regional standards. Any divergence between the IEC Standard and the corresponding national or regional standard shall be clearly indicated in the latter.
- 5) The IEC provides no marking procedure to indicate its approval and cannot be rendered responsible for any equipment declared to be in conformity with one of its standards.
- 6) Attention is drawn to the possibility that some of the elements of this International Standard may be the subject of patent rights. The IEC shall not be held responsible for identifying any or all such patent rights.

International Standard IEC 61000-4-10 has been prepared by subcommittee 77B: High frequency phenomena, of IEC technical committee 77: Electromagnetic compatibility.

It forms part 4-10 of IEC 61000. It has the status of a basic EMC publication in accordance with IEC Guide 107.

This consolidated version of IEC 61000-4-10 consists of the first edition (1993) [documents 77B(CO)9 and 77B(CO)15] and its amendment 1 (2000) [documents 77B/291+293/FDIS and 77B/298+300/RVD].

The technical content is therefore identical to the base edition and its amendment and has been prepared for user convenience.

It bears the edition number 1.1.

A vertical line in the margin shows where the base publication has been modified by amendment 1.

Annexes A and B form an integral part of this standard.

Annexes C, D and E are for information only.

The committee has decided that the contents of the base publication and its amendment will remain unchanged until 2002. At this date, the publication will be

- reconfirmed;
- withdrawn;
- replaced by a revised edition, or
- amended.

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INTRODUCTION

This standard is part of the IEC 61000 series, according to the following structure:

Part 1: General

General considerations (introduction, fundamental principles)

Definitions, terminology

Part 2: Environment

Description of the environment

Classification of the environment

Compatibility levels

Part 3: Limits

Emission limits

Immunity limits (in so far as they do not fall under the responsibility of the product committees)

Part 4: Testing and measurement techniques

Measurement techniques

Testing techniques

Part 5: Installation and mitigation guidelines

Installation guidelines

Mitigation methods and devices

Part 9: Miscellaneous

Each part is further subdivided into sections which are to be published either as international standards or as technical reports.

These standards and reports will be published in chronological order and numbered accordingly.

This part is an international standard which gives immunity requirements and test procedures related to "damped oscillatory magnetic field".

ELECTROMAGNETIC COMPATIBILITY (EMC) -

Part 4-10: Testing and measurement techniques – Damped oscillatory magnetic field immunity test

1 Scope

This international standard relates to the immunity requirements of equipment, only under operational conditions, to damped oscillatory magnetic disturbances related to medium voltage and high voltage sub-stations.

The applicability of this standard to equipment installed in different locations is determined by the presence of the phenomenon, as specified in clause 3.

This standard does not consider disturbances due to capacitive or inductive coupling in cables or other parts of the field installation.

Other IEC standards dealing with conducted disturbances cover these aspects.

The object of this standard is to establish a common and reproducible basis for evaluating the performance of electrical and electronic equipment for medium voltage and high voltage substations when subjected to damped oscillatory magnetic fields.

The standard has the object to define:

- recommended test levels;
- test equipment;
- test set-up;
- test procedure.

2 Normative reference

The following normative documents contain provisions which, through reference in this text, constitute provisions of this section of IEC 61000-4. At the time of publication, the editions indicated were valid. All normative documents are subject to revision, and parties to agreements based on this section of IEC 61000-4 are encouraged to investigate the possibility of applying the most recent editions of the normative documents indicated below. Members of IEC and ISO maintain registers of currently valid International Standards.

IEC 60068-1:1988, Environmental testing – Part 1: General and guidance

3 General

The magnetic fields to which equipment is subjected may influence the reliable operation of equipment and systems.

The following tests are intended to demonstrate the immunity of equipment when subjected to damped oscillatory magnetic field related to the specific location and installation condition of the equipment (e.g. proximity of equipment to the disturbance source).

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The damped oscillatory magnetic field is generated by the switching of H.V. bus-bars by isolators.

The test is mainly applicable to electronic equipment to be installed in H.V. sub-stations. Possible other applications may be considered by the product committees.

The test field consists of a damped oscillatory wave (see figure 2) whose characteristics are given in 6.1.1

Information on the oscillation frequency is given in annex E.

4 Definitions

The following definitions and terms are used in this standard and apply to the restricted field of magnetic disturbances; not all of them are included in IEC 60050(161) [IEV].

4.1

EUT

equipment under test

4.2

induction coil

conductor loop of defined shape and dimensions, in which flows a current, generating a magnetic field of defined constancy in its plane and in the enclosed volume

4.3

induction coil factor

ratio between the magnetic field strength generated by an induction coil of given dimensions and the corresponding current value; the field is that measured at the centre of the coil plane, without the EUT

4.4

immersion method

method of application of the magnetic field to the EUT, which is placed in the centre of an induction coil (figure 1)

4.5

proximity method

method of application of the magnetic field to the EUT, where a small induction coil is moved along the side of the EUT in order to detect particularly sensitive areas

4.6

ground (reference) plane (GRP)

a flat conductive surface whose potential is used as a common reference for the magnetic field generator and the auxiliary equipment (the ground plane can be used to close the loop of the induction coil, as in figure 5) [IEV 161-04-36, modified]

4.7

decoupling network, back filter

electrical circuit intended to avoid reciprocal influence with other equipment not submitted to the magnetic field test

4.8

burst

a sequence of a limited number of distinct pulses or an oscillation of limited duration [IEV 161-02-07]

5 Test levels

The preferential range of test levels is given in table 1.

The magnetic field strength is expressed in A/m; 1 A/m corresponds to a free space induction of 1,26 $\mu T.$

Level	Damped oscillatory magnetic field strength A/m (peak)	
1	n.a. ²⁾	
2	n.a. ²⁾	
3	10	
4	30	
5	100	
x ¹⁾	special	
NOTE 1 "x" is an open level. This level, as well the duration of the test, can be given in the product specification. NOTE 2 "n.a." = not applicable.		

Table 1 – Test levels

Information on the selection of the test levels is given in annex C.

Information on actual levels is given in annex D.

The duration of the test is 2 s.

6 Test equipment

The test magnetic field is obtained by a current flowing in an induction coil; the application of the test field to the EUT is by the *immersion method*.

An example of application of the immersion method is given in figure 1.

The test equipment includes the current source (test generator), the induction coil and auxiliary test instrumentation.

6.1 Test generator

The generator, with the output waveform corresponding to the test magnetic field, shall be able to deliver the required current in the induction coils specified in 6.2.

The generator power capability shall therefore be dimensioned by taking into account the coil impedance; the inductance may range from 2,5 μ H for the 1 m standard coil, to several μ H (e.g. 6 μ H) for a rectangular induction coil (1 m × 2,6 m, see 6.2).

The specifications of the generator are:

- current capability, determined by the maximum selected test level and induction coil factor (see 6.2.2 and annex A), ranging from 0,87 (1 m standard coil for testing table-top or small equipment to 0,66 (rectangular induction coil, 1 m × 2,6 m, for testing floor-standing or large equipment).
- operability in short-circuit condition;

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- low output terminal connected to the earth terminal (for connection to the safety earth of the laboratory);
- precautions to prevent the emission of large disturbances that may be injected in the power supply network or may influence the test results.

The characteristics and performances of the current source or test generator for the field considered in this standard are given in 6.1.1.

6.1.1 Characteristics and performances of the test generator

The test generator is a repetitive damped sinusoid current generator with characteristics as follows:

Specifications

Oscillation frequency:	0,1 MHz and 1 MHz \pm 10 %			
Decay rate:	50 % of the peak value after 3 to 6 cycles			
Repetition rate:	at least 40 transients/s at 0,1 MHz, 400 transients/s at 1 MHz			
Test duration:	2 s (+10 %, -0 %) or continuous			
Output current range:	from 10 A to 100 A, divided by the coil factor			
NOTE The output current range for the standard coil is from 12 A to 120 A.				

The waveform of the output current is given in figure 2.

The schematic circuit of the generator is given in figure 3.

6.1.2 Verification of the characteristics of the test generator

In order to compare the results for different test generators, the essential characteristics of the output current parameters shall be verified.

The output current shall be verified with the generator connected to the standard induction coil specified in 6.2.1 a); the connection shall be realized by twisted conductors or coaxial cable of up to 3 m length and suitable cross-section.

The emission of disturbances by the generator shall be verified (see 6.1).

The characteristics to be verified are:

- output current peak value;
- damping;
- frequency of oscillation;
- repetition rate.

The verifications shall be carried out with a current probe and oscilloscope or other equivalent measurement instrumentation with 10 MHz minimum bandwidth.

The accuracy of the measurements shall be ± 10 %.

6.2 Induction coil

6.2.1 Characteristics of the induction coil

The induction coil, connected to the test generator previously defined (see 6.1.1), shall generate a field strength corresponding to the selected test level and the defined homogeneity.

The induction coil shall be made of copper, aluminium or any conductive non-magnetic material, of such cross-section and mechanical arrangement as to facilitate its stable positioning during the tests.

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The coil shall be "single turn" and have a suitable current capability, as necessary for the selected test level.

The induction coil shall be adequately dimensioned to surround the EUT (three orthogonal positions).

Depending on the size of the EUT, induction coils of different dimensions may be used.

The dimensions recommended below are suitable for the generation of magnetic field over the whole volume of the EUTs (table-top equipment or floor-standing equipment), with an acceptable variation of ± 3 dB.

The characteristics of induction coils in respect of the magnetic field distribution are given in annex B.

a) Induction coil for table-top equipment

The induction coil of standard dimensions for testing small equipment (e.g. computer monitors, watt-hour meters, transmitters for process control, etc.) has a square (or circular) form with 1 m side (or diameter), made of a conductor of relatively small cross-section.

The test volume of the standard square coil is 0,6 m \times 0,6 m \times 0,5 m (height).

A double coil of standard size (Helmholtz coil) could be used in order to obtain a field homogeneity better than 3 dB or for testing larger EUTs.

The double coil (Helmholtz coil) shall be comprised of two or more series of turns, properly spaced (see figure 7, figure B.4, figure B.5).

The test volume of a double standard size coil, 0,8 m spaced, for a 3 dB homogeneity is 0,6 m \times 0,6 m \times 1 m (height).

For example, the Helmholtz coils, for a 0,2 dB inhomogeneity, have dimensions and separation distances as given in figure 7.

b) Induction coil for floor-standing equipment

Induction coils shall be made according to the dimensions of the EUT and the different field polarizations.

The coil shall be able to envelop the EUT; the coil dimensions shall be such as to give a minimum distance of coil conductors to EUT walls equal to 1/3 of the dimension of the EUT considered.

The coils shall be made of conductors of relatively small cross-section.

NOTE Due to the possible large dimensions of EUTs, the coils may be made of "C" or "T" sections in order to have sufficient mechanical rigidity.

The test volume is determined by the testing area of the coil (60 $\% \times 60$ % of each side) multiplied by a depth corresponding to 50 % of the shorter side of the coil.

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6.2.2 Calibration of the induction coil, coil factor

In order to make it possible to compare the test results from different test equipment, the induction coils shall be calibrated in their operating condition, before conducting the test (without the EUT, in free space condition).

An induction coil of the correct dimensions for the EUT dimensions, shall be positioned at 1 m minimum distance from the wall of the laboratory and any magnetic material, by using insulating supports, and shall be connected to the test generator as prescribed in 6.1.2.

Appropriate magnetic field sensors (B.W. > 10 MHz), with dynamics and frequency response in accordance with the oscillatory field, shall be used to verify the magnetic field strength generated by the induction coil.

The field sensor shall be positioned at the centre of the induction coil (without the EUT) and with suitable orientation to detect the maximum value of the field.

The current in the induction coil shall be adjusted to obtain the field strength specified by the test level.

The calibration shall be carried out at power frequency: the current value that generates a given field strength shall be used for the damped oscillatory test of the present standard.

The calibration procedure shall be carried out on the test generator and induction coils.

The coil factor is determined (and verified) by the above procedure.

The coil factor gives the current value to be injected in the coil to obtain the required test magnetic field (H/I).

Information on the measurement of the test magnetic field is given in annex A.

6.3 Test and auxiliary instrumentation

6.3.1 Test instrumentation

The test instrumentation includes:

- current measuring system (sensors and instrument) for setting and measuring the current injected in the induction coil;
- termination networks, back filters, etc., on power supply, control and signal lines.

The termination network gives a defined impedance of 50 Ω to earth for all the external circuits connected to the EUT terminals. It may be represented by the line impedance stabilization network for power supply circuits, coupling/decoupling network, or resistor-capacitor series for input/output control and signal circuits. These networks shall be described in the test plan. The termination networks, back filters, etc. shall be compatible with the operating signals.

Back filters shall be used in the connections to the simulator (see 6.3.2).

The current measuring system is a calibrated current probe or shunt; the transient current measurement instrumentation shall have a bandwidth up to 10 MHz.

The accuracy of the measurement instrumentation shall be ± 10 %.

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6.3.2 Auxiliary instrumentation

The auxiliary instrumentation comprises a simulator and any other instrument necessary for the operation and verification of the EUT functional specifications.

7 Test set-up

The test set-up comprises the following components:

- ground (reference) plane (GRP);
- equipment under test (EUT);
- test generator;
- induction coil;
- termination network, back filter.

Precautions shall be taken if the test magnetic field may interfere with the test instrumentation and other sensitive equipment in the vicinity of the test set-up.

Examples of test set-ups are given in the following figures:

Figure 4: Example of test set-up for table-top equipment

Figure 5: Example of test set-up for floor-standing equipment

7.1 Ground (reference) plane

The ground plane (GRP) shall be placed in the laboratory; the EUT and auxiliary test equipment shall be placed on it and connected to it.

The ground plane shall be a non-magnetic metal sheet (copper or aluminium) of 0,25 mm thickness; other metals may be used but in this case they shall have 0,65 mm minimum thickness.

The minimum size of the ground plane is $1 \text{ m} \times 1 \text{ m}$.

The final size depends on the dimensions of the EUT.

The ground plane shall be connected to the safety earth system of the laboratory.

7.2 Equipment under test

The equipment is configured and connected to satisfy its functional requirements. It shall be placed on the GRP with the interposition of a 0,1 m thickness insulating support (e.g. dry wood).

The equipment cabinets shall be connected to the safety earth directly on the GRP with connection of minimum length via the earth terminal of the EUT.

The power supply, input and output circuits shall be connected to the sources of power supply, control and signals via the back filters.

The cables supplied or recommended by the equipment manufacturer shall be used. In absence of any recommendation, unshielded cables shall be adopted, of a type appropriate for the signals involved. All cables shall be exposed to the magnetic field for 1 m of their length.

The back filters shall be inserted in the circuits at 1 m cable lengths from the EUT and connected to the ground plane.

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The input and output circuits, to the simulator, shall be provided with back filters in order to prevent interference to that equipment.

The communication lines (data lines) shall be connected to the EUT by the cables given in the technical specification or standard for this application. Each line in the proximity of the EUT shall be maintained at a distance of about 0,1 m from the GRP.

7.3 Test generator

The test generator shall be placed at less than 3 m distance from the induction coil.

One terminal of the generator shall be connected to the ground plane.

7.4 Induction coil

The induction coil, of the type specified in 6 2.1, shall enclose the EUT placed at its centre.

Different induction coils may be selected for testing in the different orthogonal directions, according to the general criteria specified in 6.2.1 a) and b).

Induction coils used in the vertical position (horizontal polarization of the field) can be bonded (at the foot of one vertical conductor) directly to the ground plane, which represents the low side of the coil, as a part of it. In this case, 0,1 m minimum distance from EUT to the ground plane is sufficient.

The induction coil shall be connected to the test generator in the same way as for the calibration procedure specified in 6.2.2.

The induction coil selected for the tests shall be specified in the test plan.

8 Test procedure

The test procedure shall include:

- verification of the laboratory reference conditions;
- preliminary verification of the correct operation of the equipment;
- carrying out the test;
- evaluation of the test results.

8.1 Laboratory reference conditions

In order to minimize the effect of environmental parameters on the test results, the test shall be carried out in climatic and electromagnetic reference conditions as specified in 8.1.1 and 8.1.2.

8.1.1 Climatic conditions

Unless otherwise specified by the committee responsible for the generic or product standard, the climatic conditions in the laboratory shall be within any limits specified for the operation of the EUT and the test equipment by their respective manufacturers.

Tests shall not be performed if the relative humidity is so high as to cause condensation on the EUT or the test equipment.

NOTE Where it is considered that there is sufficient evidence to demonstrate that the effects of the phenomenon covered by this standard are influenced by climatic conditions, this should be brought to the attention of the committee responsible for this standard.

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8.1.2 Electromagnetic conditions

The electromagnetic conditions of the laboratory shall be such to guarantee the correct operation of the EUT in order not to influence the test results; otherwise, the tests shall be carried out in a Faraday cage.

In particular, the electromagnetic field value of the laboratory shall be at least 20 dB lower than the selected test level.

8.2 Carrying out the test

The test shall be carried out on the basis of a test plan including verification of the performances of the EUT as defined in the technical specification.

The power supply, signal and other functional electrical quantities shall be applied within their rated range.

If the actual operating signals are not available, they may be simulated.

Preliminary verification of equipment performances shall be carried out prior to applying the test magnetic field.

The test magnetic field shall be applied by the immersion method to the EUT, previously set up as specified in 7.2.

The test level shall not exceed the product specification.

NOTE In order to detect the most susceptible side/positions of the EUT, mainly of a stationary type, the proximity method may be used for investigation purposes. This method is not to be used for certification. An example of application of the test field by proximity method is given in figure 6.

The test is performed by applying the damped oscillatory magnetic field for 2 s.

The test shall be implemented at two frequencies, at least, in the range between 30 kHz and 10 MHz. Preferably, it shall be made at 0,1 MHz and 1 MHz. Any other test frequency in the range 30 kHz and 10 MHz may be chosen by product committee or product specification; they shall be recorded in the test plan.

The test shall be made at repetition rate of at least 40 Hz for 0,1 MHz and at 400 Hz for the 1 MHz wave. The repetition rate will be increased or decreased proportionally to the test frequency.

a) Table-top equipment

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimensions $(1 \text{ m} \times 1 \text{ m})$ specified in 6.2.1 a) and shown in figure 4.

The induction coil shall then be rotated by 90° in order to expose the EUT to the test field with different orientations.

b) Floor-standing equipment

The equipment shall be subjected to the test magnetic field by using induction coils of suitable dimensions as specified in 6.2.1 b); the test shall be repeated by moving and shifting the induction coils, in order to test the whole volume of the EUT for each orthogonal direction.

The test shall be repeated with the coil shifted to different positions along the side of the EUT, in steps corresponding to 50 % of the shortest side of the coil.

NOTE The moving of the induction coil in steps corresponding to 50 % of the shortest side of the coil gives overlapping test fields.

The induction coil shall then be rotated by 90° in order to expose the EUT to the test field with different orientations and the same procedure.

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9 Evaluation of test results

The test results shall be classified in terms of the loss of function or degradation of performance of the equipment under test, relative to a performance level defined by its manufacturer or the requestor of the test, or agreed between the manufacturer and the purchaser of the product. The recommended classification is as follows:

- a) normal performance within limits specified by the manufacturer, requestor or purchaser;
- b) temporary loss of function or degradation of performance which ceases after the disturbance ceases, and from which the equipment under test recovers its normal performance, without operator intervention;
- c) temporary loss of function or degradation of performance, the correction of which requires operator intervention;
- d) loss of function or degradation of performance which is not recoverable, owing to damage to hardware or software, or loss of data.

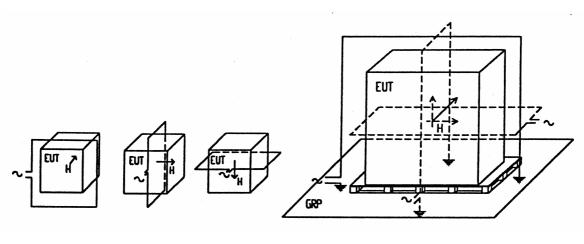
The manufacturer's specification may define effects on the EUT which may be considered insignificant, and therefore acceptable.

This classification may be used as a guide in formulating performance criteria, by committees responsible for generic, product and product-family standards, or as a framework for the agreement on performance criteria between the manufacturer and the purchaser, for example where no suitable generic, product or product-family standard exists.

10 Test report

The test report shall contain all the information necessary to reproduce the test. In particular, the following shall be recorded:

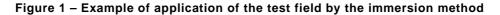
- the items specified in the test plan required by clause 8 of this standard;
- identification of the EUT and any associated equipment, for example, brand name, product type, serial number;
- identification of the test equipment, for example, brand name, product type, serial number;
- any special environmental conditions in which the test was performed, for example, shielded enclosure;
- any specific conditions necessary to enable the test to be performed;
- performance level defined by the manufacturer, requestor or purchaser;
- performance criterion specified in the generic, product or product-family standard;
- any effects on the EUT observed during or after the application of the test disturbance, and the duration for which these effects persist;
- the rationale for the pass/fail decision (based on the performance criterion specified in the generic, product or product-family standard, or agreed between the manufacturer and the purchaser);
- any specific conditions of use, for example cable length or type, shielding or grounding, or EUT operating conditions, which are required to achieve compliance.



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Table-top equipment

Floor-standing equipment



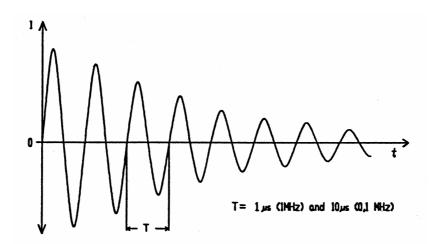


Figure 2 – Current waveform of the test generator for damped oscillatory magnetic field (sinusoid wave)

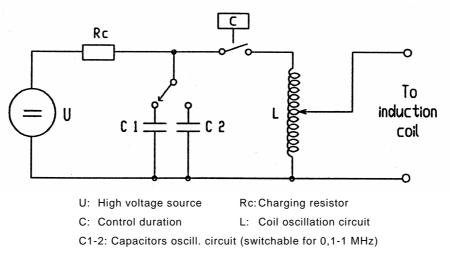


Figure 3 – Schematic circuit of the test generator for damped oscillatory magnetic field

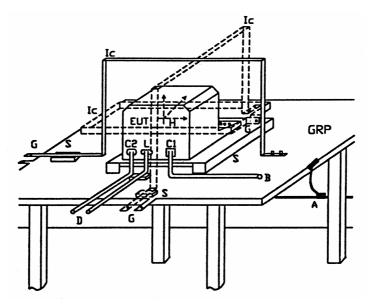


Figure 4 – Example of test set-up for table-top equipment

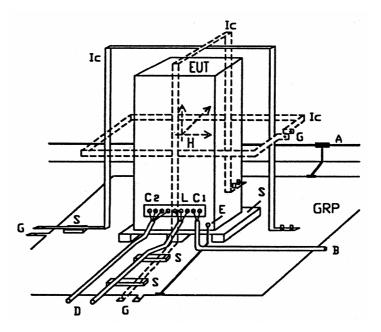


Figure 5 – Example of test set-up for floor-standing equipment

References common to figure 4 and figure 5

GRP:Ground plane

C1:Power supply circuit

- A: Safety earth
- C2:Signal circuit
- S: Insulating support
- EUT: Equipment under test
 - B: To power supply source
- Ic: Induction coil
- E: Earth terminal
- D: To signal source, simulator
- G: To the test generator

L: Communication line

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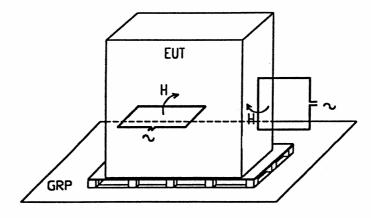
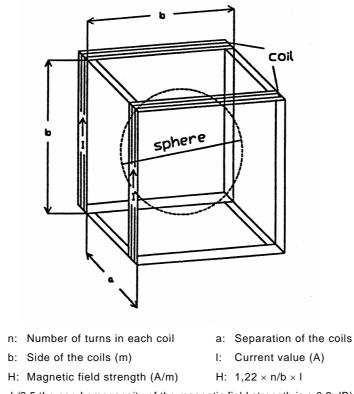


Figure 6 – Example of investigation of susceptibility to magnetic field by the proximity method



(with a = b/2,5 the non-homogeneity of the magnetic field strength is \pm 0,2 dB)

Figure 7 – Illustration of Helmholtz coils

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Annex A

(normative)

Induction coil calibration method

A.1 Magnetic field measurement

The magnetic field test is related to free space condition, without the EUT and at 1 m minimum distance from the laboratory walls and any magnetic material.

The measurement of the magnetic field may be done with a measurement system comprising wide band sensors (10 MHz minimum bandwidth, available in the market) and recording instruments e.g. transient recorders or storage oscilloscopes.

A.2 Calibration of the induction coil

The calibration shall be carried out by injecting the calibration current at power frequency in the induction coil and measuring the magnetic field by sensors placed at its geometrical centre.

Proper orientation of the sensor shall be selected in order to obtain the maximum value.

The *"induction coil factor"* shall be determined for each induction coil as the ratio "field strength/current" of injection (H/A).

The "coil factor", determined at a.c. current, is not related to the current waveform, but is a characteristic parameter of the induction coil; it is therefore applicable for the evaluation of magnetic field of different waveform, like the transient ones defined in this standard.

For standard dimension coil, the coil factor is determined by the manufacturer of the coil, and can be verified by laboratory measurements before carrying out the tests.

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Annex B (normative)

Characteristics of the induction coils

B.1 General

This annex considers the problems of generation of the test magnetic fields.

In the first stage, both the immersion and proximity methods were considered.

In order to know the limits of application of such methods, some questions have been emphasized.

In the following the reasons for the values are explained.

B.2 Induction coil requirements

The requirement of the induction coil is "3 *dB* tolerance of the test field in the volume of the *EUT*"; this tolerance has been considered a reasonable technical compromise in respect of a test characterized by severity levels in 10 dB steps, due to practical limits in the generation of constant field over a wide range of volumes.

The constancy of the field is a requirement limited to a single direction, orthogonal to the coil plane. The field in different directions is obtainable in successive test steps by rotating the induction coil.

B.3 Induction coil characteristics

The characteristics of induction coils of different dimensions suitable for testing *table-top* equipment or *floor-standing* equipment are given in diagrams showing:

- profile of the field generated by a square induction coil (1 m side) in its plane (see figure B.1);
- 3 dB area of the field generated by a square induction coil (1 m side) in its plane (see figure B.2);
- 3 dB area of the field generated by a square induction coil (1 m side) in the mean orthogonal plane (component orthogonal to the plane of the coil) (see figure B.3);
- 3 dB area of the field generated by two square induction coils (1 m side) 0,6 m spaced, in the mean orthogonal plane (component orthogonal to the plane of the coils) (see figure B.4);
- 3 dB area of the field generated by two square induction coils (1 m side) 0,8 m spaced, in the mean orthogonal plane (component orthogonal to the plane of the coils) (see figure B.5);
- 3 dB area of the field generated by a rectangular induction coil (1 m × 2,6 m) in its plane (see figure B.6);
- 3 dB area of the field generated by a rectangular induction coil (1 m × 2,6 m) in its plane (ground plane as a side of the induction coil) (see figure B.7);
- 3 dB area of the field generated by a rectangular induction coil (1 m × 2,6 m), with ground plane, in the mean orthogonal plane (component orthogonal to the plane of the coil) (see figure B.8).

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In the selection of the form, arrangement and dimensions of the test coil, the following points have been considered:

- the 3 dB area, inside and outside the induction coil, is related to the shape and dimensions of the induction coil;
- for a given field strength, driving current value, power and energy of the test generator are proportional to the dimensions of the induction coil.

B.4 Summary of characteristics of induction coils

On the basis of the data on the field distribution of coils with different sizes, and in view of adopting the test method given in this standard to different classes of equipment, the conclusions that can be drawn are as follows:

- single square coil, 1 m side: testing volume 0,6 m \times 0,6 m \times 0,5 m high (0,2 m minimum distance from EUT to the coil);
- double square coils, 1 m side, 0,6 spaced: testing volume $0,6 \times 0,6 \times 1$ m high (0,2 m minimum distance from EUT to the coil); increasing of the separation of the coils up to 0,8 m, extends the maximum high of testable EUT (see the 3 dB area, in the mean orthogonal plane) up to 1,2 m.
- single rectangular coil, 1 m × 2,6 m: testing volume 0,6 m × 0,6 m × 2 m high (0,2 and 0,3 m minimum distance from EUT to the coil, respectively for the horizontal and vertical dimensions of EUT); if the induction coil is bonded to the GRP, a 0,1 m distance from it is sufficient.



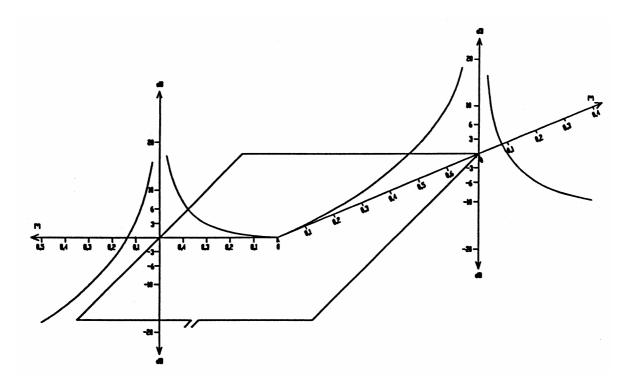


Figure B.1 – Characteristics of the field generated by a square induction coil (1 m side) in its plane

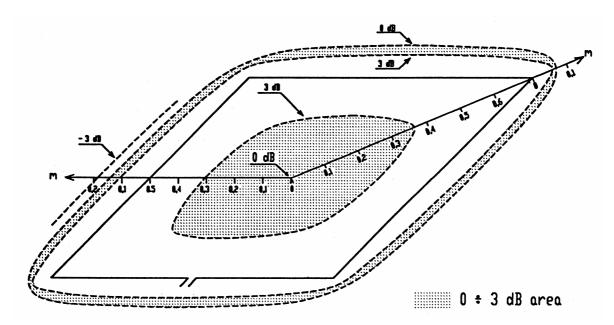
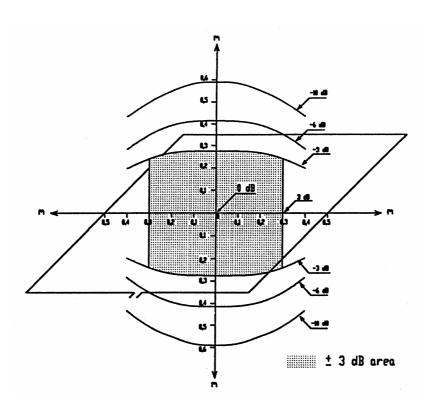


Figure B.2 – 3 dB area of the field generated by a square induction coil (1 m side) in its plane



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Figure B.3 – 3 dB area of the field generated by a square induction coil (1 m side) in the mean orthogonal plane (component orthogonal to the plane of the coil)

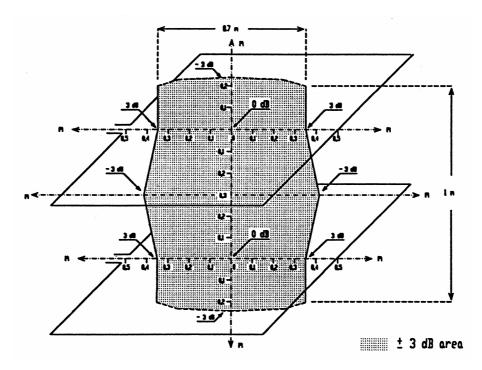


Figure B.4 – 3 dB area of the field generated by two square induction coils (1 m side) 0,6 m spaced, in the mean orthogonal plane (component orthogonal to the plane of the coils)

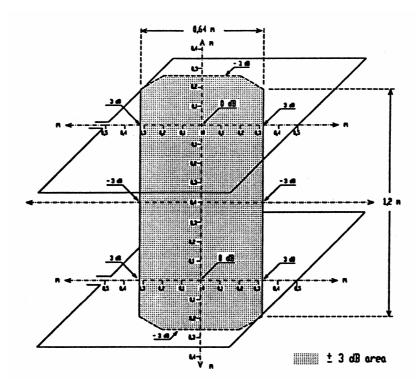


Figure B.5 – 3 dB area of the field generated by two square induction coils (1 m side) 0,8 m spaced, in the mean orthogonal plane (component orthogonal to the plane of the coils)

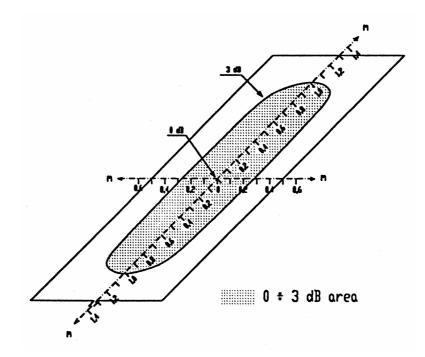


Figure B.6 – 3 dB area of the field generated by a rectangular induction coil (1 m \times 2,6 m) in its plane

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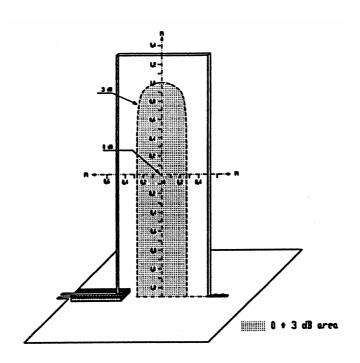


Figure B.7 – 3 dB area of the field generated by a rectangular induction coil $(1 \text{ m} \times 2.6 \text{ m})$ in its plane (ground plane as a side of the induction coil)

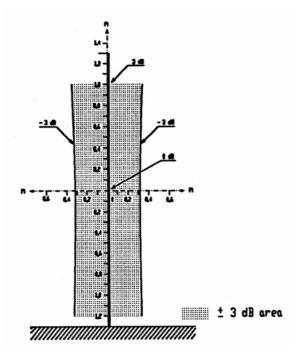


Figure B.8 – 3 dB area of the field generated by a rectangular induction coil $(1 \text{ m} \times 2,6 \text{ m})$ with ground plane, in the mean orthogonal plane (component orthogonal to the plane of the coil)

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Annex C

(informative)

Selection of the test levels

The test levels shall be selected in accordance with the most realistic installation and environmental conditions.

These levels are outlined in clause 5.

The immunity tests are correlated with these levels in order to establish a performance level for the environment in which the equipment is expected to operate.

The test level shall be chosen according to:

- the electromagnetic environment;
- the proximity of the disturbance sources to the equipment concerned;
- the compatibility margins.

Based on common installation practices, a guide for the selection of test levels for damped oscillatory magnetic fields testing may be the following:

- *Class 1:* Test not applicable to this environment where sensitive device using electron beam can be used (*monitors, electron microscope, etc.,* are representative of these devices).
- Class 2: Well protected environment

Test not applicable to this environmental class because the areas concerned are not subjected to the influence of switching of H.V. bus-bars by isolators.

Shielded areas of industrial installations and H.V. sub-stations may be representative of this environment.

Class 3: Protected environment

The environment is characterized by M.V. circuits and H.V. bus-bars switched by isolators far away (a few hundred metres) from equipment concerned.

Computer room of H.V. sub-stations may be representative of this environment.

Class 4: Typical industrial environment

The environment is characterized by M.V. circuits and H.V. bus-bars switched by isolators at relative distance (a few tens of metres) from equipment concerned.

Fields of heavy industrial and power plants and the control room of H. V. sub-stations may be representative of this environment.

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Class 5: Severe industrial environment

The environment is characterized by the following attributes:

- proximity of M.V. and H.V. bus-bars switched by isolators;
- proximity of high power electrical equipment.

Switchyard areas of heavy industrial plants, M.V., H.V. and power stations may be representative of this environment.

Class X: Special environment

The minor or major electromagnetic separation of interference sources from equipment circuits, cables, lines etc., and the quality of the installations may require the use of a higher or lower environmental level than those described above.

It should be noted that the equipment lines of a higher level can penetrate a lower severity environment.

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Annex D (informative)

Information on magnetic field strength

Data are restricted to prediction of the environment and field measurements on the operation of H.V. bus-bar isolators.

The prediction of the magnetic field under the H.V. bus-bars, in the aperture of isolators, gives values up to 100 A/m (peak).

Measurements carried out by using wide band sensors, at different H.V. sub-station locations show values ranging from 10 A/m (peak) in the sub-station area up to 100 A/m (peak) in the proximity of the capacitive voltage transformers.

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Annex E

(informative)

Damped oscillatory magnetic field frequency

The phenomenon is typical of switching of isolators in H.V. sub-stations, and particularly in H.V. bus-bars.

The opening and closing operation of H.V. isolators gives rise to sharp front-wave transients, with time of the order of tens of ns; in propagation in H.V. circuits (bus-bars) these phenomena are smoothed by the overall capacitance of the structures of H.V. equipment.

The voltage front-wave has an evolution that includes reflections due to the mismatching of the characteristic impedance of H.V. circuits involved. In this respect, the resulting transient voltage and current in H.V. bus-bars is characterized by a fundamental oscillation frequency that depends on the length of the circuit and on the propagation time.

The transient current peak value, that generates the magnetic field object of this part of the standard, is directly related to the peak voltage on the bus-bars and their characteristic impedance; the voltage is about twice the phase peak value of the H.V. system and the current (determined also by the characteristic impedance of such circuits) is about 2 kA peak.

The frequency of oscillation is determined by the length of the H.V. and by the self-inductance of H.V. circuits (1 μ H/m), series capacity of the circuit-breaker in the off-state (500 pF), concentrated capacity of capacitive voltage transformers (some nF), of current transformers (300 pF) and of H.V. supports (20 pF each).

The oscillation frequency ranges from about 100 kHz to a few MHz depending on the influence of the parameter yet mentioned and the length of the bus-bars, that may vary from tens of m to hundreds of m (400 m may occur).

In this respect the oscillation frequency of 1 MHz may be considered representative of most situations, but 100 kHz has been considered appropriate for big H.V. sub-stations.

The repetition frequency is variable and, provided the other conditions are the same, is a function of the distance between the switching contacts: that is, with closed contacts, there is the maximum repetition frequency, while for distances between the contacts at the limit of extinction of the arc, the minimum repetition frequency in respect of each phase is twice the power frequency (100/s for 50 Hz and 120/s for 60 Hz H.V. systems), but at these frequencies the maximum magnetic field strength occurs.

The repetition rates selected for the 0,1 MHz and 1 MHz test fields represent therefore a compromise, taking into account the different duration of the phenomena, the representativity of the different frequencies and the problems related to the power of the test generator.